WF128K16, WF256K16-XCX5

5V FLASH MODULE

PRELIMINARY *

FEATURES

- Access Times of 50, 60, 70, 90, 120 and 150ns
- 40 pin Ceramic DIP (Package 303)
- Organized as 128Kx16 and 256Kx16
- Sector Architecture
 - 8 equal size sectors of 16KBytes each per chip
 - Any combination of sectors can be concurrently erased. Also supports full chip erase
- 100,000 Erase/Program Cycles Minimum (0°C to 70°C)
- Data Retention, 10 Years at 125°C
- Commercial, Industrial and Military Temperature Ranges

- 5 Volt Programming; 5V ±10% Supply
- Low Power CMOS
- Embedded Erase and Program Algorithms
- TTL Compatible Inputs and CMOS Outputs
- Built-in Decoupling Caps and Multiple Ground Pins for Low Noise Operation
- Page Program Operation and Internal Program Control Time
- This data sheet describes a product under development, not fully characterized, and is subject to change without notice.
 Note: Programming information available upon request.



PIN DESCRIPTION

A0-16	Address Inputs
I/O0-15	Data Input/Output
<u>CS</u> 1-2	Chip Selects
ŌĒ	Output Enable
WE	Write Enable
Vcc	+5.0V Power
GND	Ground

BLOCK DIAGRAM FOR WF256K16-XCX5



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ABSOLUTE MAXIMUM RATINGS (1)

Parameter		Unit
Operating Temperature	-55 to +125	°C
Supply Voltage Range (Vcc)	-2.0 to +7.0	V
Signal voltage range (any pin except A9) (2)	-2.0 to +7.0	V
Storage Temperature Range	-65 to +150	°C
Lead Temperature (soldering, 10 seconds)	+300	°C
Data Retention Mil Temp	10 years	
Endurance (write/erase cycles) Mil Temp	10,000 cycles min.	
A9 Voltage for sector protect (VID) (3)	-2.0 to +14.0	V

NOTES:

- Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.
- bit devices. Extended operation at the maximum reversing degrade performance and affect reliability.
 Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, inputs may overshoot Vss to -2.0 V for periods of up to 20ns. Maximum DC voltage on output and I/O pins is Vcc + 0.5V. During voltage transitions, outputs may overshoot to Vcc + 2.0 V for periods of up to 20ns.
- Minimum DC input voltage on A9 pin is -0.5V. During voltage transitions, A9 may overshoot Vss to -2V for periods of up to 20ns. Maximum DC input voltage on A9 is +13.5V which may overshoot to 14.0 V for periods up to 20ns.

CAPACITANCE

 $(TA = 25^{\circ}C)$

Test	Symbol	Conditions	Max	Unit
OE capacitance	COE	VIN = 0 V, f = 1.0 MHz	50	pF
WE capacitance	Cwe	VIN = 0 V, f = 1.0 MHz	50	рF
CS capacitance	Ccs	VIN = 0 V, f = 1.0 MHz	30	рF
I/Oo-7 capacitance	Ci/o	Vi/o = 0 V, f = 1.0 MHz	30	рF
Address capacitance	CAD	VIN = 0 V, f = 1.0 MHz	50	рF

This parameter is guaranteed by design but not tested.

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Max	Unit
Supply Voltage	Vcc	4.5	5.5	V
Input High Voltage	Vін	2.0	Vcc + 0.3	V
Input Low Voltage	Vil	-0.5	+0.8	V
Operating Temp. (Mil.)	TA	-55	+125	°C
Operating Temp. (Ind.)	TA	-40	+85	°C
A9 Voltage for Sector Protect	Vid	11.5	12.5	V

DC CHARACTERISTICS - CMOS COMPATIBLE

 $(VCC = 5.0V, VSS = 0V, TA = -55^{\circ}C \text{ to } +125^{\circ}C)$

Parameter	Symbol	Conditions 128K x 16			256K	Unit	
			Min	Max	Min	Max	
Input Leakage Current	Lu	Vcc = 5.5, VIN = GND to Vcc		10		10	μA
Output Leakage Current	ILO	Vcc = 5.5, $Vin = GND$ to Vcc		10		10	μA
Vcc Active Current for Read (1)	Icc1	$\overline{\text{CS}}$ = VIL, $\overline{\text{OE}}$ = VIH		70		80	mA
Vcc Active Current for Program or Erase (2)	ICC2	$\overline{\text{CS}}$ = VIL, $\overline{\text{OE}}$ = VIH		100		110	mA
Vcc Standby Current	Іссз	Vcc = 5.5, \overline{CS} = VIH, f = 5MHz		6		8	mA
Output Low Voltage	Vol	IoL = 12.0 mA, Vcc = 4.5		0.45		0.45	V
Output High Voltage	Vон1	Іон = -2.5 mA, Vcc = 4.5	0.85xVcc		0.85xVcc		V
Output High Voltage	Vон2	Іон = -100 µА, Vcc = 4.5	Vcc -0.4		Vcc -0.4		V
Low Vcc Lock Out Voltage	Vlko		3.2		3.2		V

NOTES:

1. The lcc current listed includes both the DC operating current and the frequency dependent component (at 5 MHz).

The frequency component typically is less than 2 mÅ/MHz, with OE at VIH.

2. Icc active while Embedded Algorithm (program or erase) is in progress.

3. DC test conditions: VIL = 0.3V, VIH = VCC - 0.3V

WF128K16, WF256K16-XCX5

PRINCIPLES OF OPERATION

The following principles of operation of the WF128K16-XCX5 and WF256K16-XCX5 are applicable to each 128K x 8 memory chip inside the MCM. Programming of the device is accomplished by executing the program command sequence. The program algorithm, which is an internal algorithm, automatically times the program pulse widths and verifies proper cell margin. Sectors can be programmed and verified in less than 0.3 seconds. Erase is accomplished by executing the erase command sequence. The erase algorithm, which is internal, automatically preprograms the array if it is not already programmed before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin. The entire memory is typically erased and verified in three seconds (including pre-programming).

WRITE

Device erasure and programming are accomplished via the command register. The contents of the register serve as input to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy an addressable memory location. The register is a latch used to store the commands, along with address and data information needed to execute the command. The command register is written by bringing Write-Enable to a logic-low level (VIL), while Chip-Select is low and \overline{OE} is at VIH. Addresses are latched on the falling edge of the Write-Enable while data is latched on the rising edge of the Write-Enable while data is latched on the rising edge of the \overline{WE} pulse. Standard microprocessor write timings are used. Refer to AC Program characteristics, Figures 4 and 7.

BUS OPERATIONS

READ

The device has two control functions, both of which must be logically active, to obtain data at the outputs. Chip-Select ($\overline{\text{CS}}$) is the power control and should be used for device selection. Output-Enable ($\overline{\text{OE}}$) is the output control and should be used to gate data to the output pins. Figure 3 illustrates read timing waveforms.

OUTPUT DISABLE

With Output-Enable at a logic-high level (VIH), output from the device is disabled. Output pins are placed in a high impedance state.

STANDBY MODE

The device has two standby modes, a CMOS standby mode (\overline{CS} input held at Vcc + 0.5V), and a TTL standby mode (\overline{CS} is held ViH). In the standby mode the outputs are in a high impedance state, independent of the \overline{OE} input.

If the device is deselected during erasure or programming, the device will draw active current until the operation is completed.

TABLE 1 - BUS OPERATIONS

Operation	CS	ŌE	WE	Ao	A1	A9	I/O
Read	L	L	Н	Ao	A 1	A9	Dout
Standby	Н	х	х	х	х	х	HIGH Z
Output Disable	L	Н	Н	Х	х	х	HIGH Z
Write	L	Н	L	Ao	A1	A9	Din
Enable Sector Protect	L	Vid	L	Х	х	Vid	Х
Verify Sector Protect	L	L	Н	L	Н	Vid	Code

WHITE MICROELECTRONICS WF128K16, WF256K16-XCX5

AC CHARACTERISTICS - WRITE/ERASE/PROGRAM OPERATIONS, WE CONTROLLED

Parameter	Sym	ıbol	ol <u>-50</u>		<u>-60</u>		<u>-70</u>		<u>-90</u>		<u>-120</u>		<u>-150</u>		Unit
			Min	Мах	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Write Cycle Time	tavav	twc	50		60		70		90		120		150		ns
Chip Select Setup Time	telwl	tcs	0		0		0		0		0		0		ns
Write Enable Pulse Width	twlwн	twp	25		30		35		45		50		50		ns
Address Setup Time	tavwl	tas	0		0		0		0		0		0		ns
Data Setup Time	tdvwн	tos	25		30		30		45		50		50		ns
Data Hold Time	twнdx	tdн	0		0		0		0		0		0		ns
Address Hold Time	twlax	tан	40		45		45		45		50		50		ns
Chip Select Hold Time	twhen	tсн	0		0		0		0		0		0		ns
Write Enable Pulse Width High	twhwl	twpн	20		20		20		20		20		20		ns
Duration of Byte Programming Operation (min)	twhwh1		14		14		14		14		14		14		μs
Chip and Sector Erase Time	twhwh2		2.2	60	2.2	60	2.2	60	2.2	60	2.2	60	2.2	60	sec
Read Recovery Time Before Write	tghwl		0		0		0		0		0		0		ns
Vcc Setup Time		tvcs	50		50		50		50		50		50		μs
Chip Programming Time				12.5		12.5		12.5		12.5		12.5		12.5	sec
Output Enable Setup Time		toes	0		0		0		0		0		0		ns
Output Enable Hold Time (1)		tоен	10		10		10		10		10		10		ns

 $(Vcc = 5.0V, Vss = 0V, Ta = -55^{\circ}C to + 125^{\circ}C)$

1. For Toggle and Data Polling.

AC CHARACTERISTICS – READ ONLY OPERATIONS

 $(VCC = 5.0V, VSS = 0V, TA = -55^{\circ}C \text{ to } +125^{\circ}C)$

Parameter	Symbol		<u>-50</u>		<u>-60</u>		<u>-70</u>		<u>-90</u>		<u>-120</u>		<u>-150</u>		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Read Cycle Time	tavav	trc	50		60		70		90		120		150		ns
Address Access Time	tavqv	tacc		50		60		70		90		120		150	ns
Chip Select Access Time	telav	tce		50		60		70		90		120		150	ns
OE to Output Valid	tglav	toe		25		30		35		40		50		55	ns
Chip Select to Output High Z (1)	tенoz	tdf		20		20		20		25		30		35	ns
OE High to Output High Z (1)	tgнqz	tdf		20		20		20		25		30		35	ns
Output Hold from Address, $\overline{\text{CS}}$ or $\overline{\text{OE}}$ Change, whichever is first	taxox	tон	0		0		0		0		0		0		ns

1. Guaranteed by design, not tested.

WHITE MICROELECTRONICS WF128K16, WF256K16-XCX5

AC CHARACTERISTICS - WRITE/ERASE/PROGRAM OPERATIONS, CS CONTROLLED

Parameter	Sym	Symbol		Symbol		<u>-50</u>		<u>-60</u>		-70		<u>-90</u>		<u>-120</u>		<u>-150</u>	
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max			
Write Cycle Time	tavav	twc	50		60		70		90		120		150		ns		
WE Setup Time	twlel	tws	0		0		0		0		0		0		ns		
CS Pulse Width	t eleh	tcp	25		30		35		45		50		50		ns		
Address Setup Time	tavel	tas	0		0		0		0		0		0		ns		
Data Setup Time	tdveh	tos	25		30		30		45		50		50		ns		
Data Hold Time	tенdх	tdн	0		0		0		0		0		0		ns		
Address Hold Time	telax	tан	40		45		45		45		50		50		ns		
WE Hold from WE High	tенwн	twн	0		0		0		0		0		0		ns		
CS Pulse Width High	t ehel	tсрн	20		20		20		20		20		20		ns		
Duration of Programming Operation	twhwh1		14		14		14		14		14		14		μs		
Duration of Erase Operation	twhwh2		2.2	60	2.2	60	2.2	60	2.2	60	2.2	60	2.2	60	sec		
Read Recovery before Write	t GHEL		0		0		0		0		0		0		ns		
Chip Programming Time				12.5		12.5		12.5		12.5		12.5		12.5	sec		

 $(VCC = 5.0V, VSS = 0V, TA = -55^{\circ}C \text{ to } +125^{\circ}C)$















